

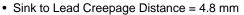
RoHS

# AFP2309AS23RG-VB Datasheet P-Channel 60-V (D-S) MOSFET

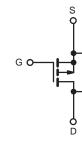
PRODUCT SUMMA	ODUCT SUMMARY				
V <sub>DS</sub> (V)	- 60	)			
$R_{DS(on)}\left(\Omega\right)$	V <sub>GS</sub> = - 10 V	0.05			
Q <sub>g</sub> (Max.) (nC)	12				
Q <sub>gs</sub> (nC)	3.8				
Q <sub>gd</sub> (nC)	5.1				
Configuration	Sing	le			

#### **FEATURES**

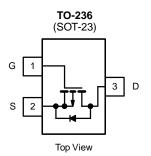
- · Isolated Package
- High Voltage Isolation = 2.5 kV<sub>RMS</sub> (t = 60 s; f = 60 Hz



- P-Channel
- 175 °C Operating Temperature
- · Dynamic dV/dt Rating
- · Low Thermal Resistance
- Lead (Pb)-free Available



P-Channel MOSFET



ABSOLUTE MAXIMUM RATINGS T	<sub>C</sub> = 25 °C, ur	nless otherw	rise noted		
PARAMETER			SYMBOL	LIMIT	UNIT
Drain-Source Voltage			$V_{DS}$	- 60	V
Gate-Source Voltage		$V_{GS}$	± 20	V	
Continuous Drain Current	V <sub>GS</sub> at - 10 V	$T_C = 25 ^{\circ}C$	I-	- 5.2	
Continuous Drain Current	VGS at - 10 V	$T_C = 100 ^{\circ}C$	I <sub>D</sub>	- 3.8	Α
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	- 21	
Linear Derating Factor				0.18	W/°C
Single Pulse Avalanche Energy <sup>b</sup>			E <sub>AS</sub>	120	mJ
Repetitive Avalanche Currenta			I <sub>AR</sub>	- 5.2	Α
Repetitive Avalanche Energy <sup>a</sup>			E <sub>AR</sub>	2.7	mJ
Maximum Power Dissipation	T <sub>C</sub> =	25 °C	$P_{D}$	27	W
Peak Diode Recovery dV/dtc			dV/dt	- 4.5	V/ns
Operating Junction and Storage Temperature Range			$T_J,T_stg$	- 55 to + 175	°C
Soldering Recommendations (Peak Temperature)	for 1	0 s		300 <sup>d</sup>	
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in
woulding rorque				1.1	N · m

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b.  $V_{DD}$  = 25 V, starting  $T_J$  = 25 °C, L = 5.0 mH,  $R_G$  = 25  $\Omega$ ,  $I_{AS}$  = 5.3 A (see fig. 12). c.  $I_{SD} \le$  6.7 A,  $dI/dt \le$  90 A/ $\mu$ s,  $V_{DD} \le$   $V_{DS}$ ,  $T_J \le$  175 °C.
- d. 1.6 mm from case.



THERMAL RESISTANCE RAT	rings			
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	$R_{thJA}$	-	65	°C/W
Maximum Junction-to-Case (Drain)	$R_{thJC}$	-	5.5	C/VV

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$		- 60	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	Reference to 25 °C, I <sub>D</sub> = - 1 mA		- 0.060	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =	V <sub>GS</sub> , I <sub>D</sub> = - 250 μA	- 1.0	-	- 2.5	V
Gate-Source Leakage	I <sub>GSS</sub>	,	V <sub>GS</sub> = ± 20 V	-	-	± 100	nA
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> =	V <sub>DS</sub> = - 60 V, V <sub>GS</sub> = 0 V		-	- 100	ι. Λ
		V <sub>DS</sub> = - 48	V <sub>GS</sub> = 0 V, T <sub>J</sub> = 150 °C	-	-	- 500	μA
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = - 10 V	I <sub>D</sub> = - 3.2 A <sup>b</sup>	-	0.05	-	Ω
Forward Transconductance	9 <sub>fs</sub>	V <sub>DS</sub> =	- 25 V, I <sub>D</sub> = - 3.2 A <sup>b</sup>	1.6	-	-	S
Dynamic							
Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> = 0 V,		-	270	-	
Output Capacitance	C <sub>oss</sub>		$V_{DS} = -25 \text{ V},$		170	-	
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1.	.0 MHz, see fig. 5	-	31	-	pF
Drain to Sink Capacitance	С		f = 1.0 MHz	-	12	-	
Total Gate Charge	Qg			-	-	12	
Gate-Source Charge	Q <sub>gs</sub>	V <sub>GS</sub> = - 10 V	$I_D = -4.7 \text{ A}, V_{DS} = -48 \text{ V},$ see fig. 6 and $13^b$	-	-	3.8	nC
Gate-Drain Charge	Q <sub>gd</sub>	7		-	-	5.1	
Turn-On Delay Time	t <sub>d(on)</sub>	$V_{DD}$ = - 30 V, $I_{D}$ = - 4.7 A, $R_{G}$ = 24 $\Omega$ , $R_{D}$ = 4.0 $\Omega$ , see fig. 10 <sup>b</sup>		-	11	-	- ns
Rise Time	t <sub>r</sub>			-	63	-	
Turn-Off Delay Time	t <sub>d(off)</sub>			-	9.6	-	
Fall Time	t <sub>f</sub>			-	31	-	
Internal Drain Inductance	L <sub>D</sub>	6 mm (0.25")	Between lead, 6 mm (0.25") from		4.5	-	-11
Internal Source Inductance	L <sub>S</sub>	package and center of die contact		-	7.5	-	nH
Drain-Source Body Diode Characteristic	s	1					
Continuous Source-Drain Diode Current	I <sub>S</sub>	showing the	MOSFET symbol showing the		-	- 5.2	А
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>	integral reverse p - n junction diode		ı	-	- 21	
Body Diode Voltage	$V_{SD}$	$T_J = 25  ^{\circ}\text{C},  I_S = -5.2  \text{A},  V_{GS} = 0  \text{V}^{\text{b}}$		-	-	- 5 .5	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	$T_J = 25  ^{\circ}\text{C}, \ I_F = -4.7  \text{A}, \ \text{dI/dt} = 100  \text{A/}\mu\text{s}^b$		-	80	160	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			_	0.096	0.19	μC
Forward Turn-On Time	t <sub>on</sub>	Intrinsic tu	on is dor	ninated by	/ L <sub>S</sub> and I	_D)	

## Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width  $\leq 300~\mu s;$  duty cycle  $\leq 2~\%.$



## TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

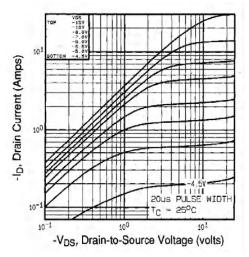


Fig. 1 - Typical Output Characteristics, T<sub>C</sub>= 25 °C

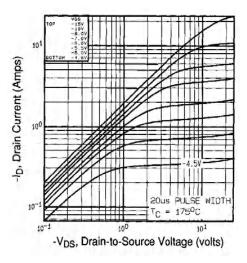


Fig. 2 - Typical Output Characteristics,  $T_{C}$ = 175 °C

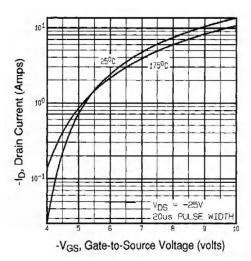


Fig. 3 - Typical Transfer Characteristics

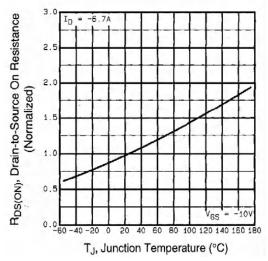


Fig. 4 - Normalized On-Resistance vs. Temperature



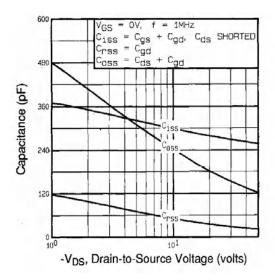


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

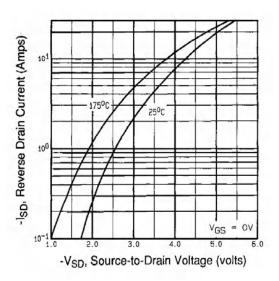


Fig. 7 - Typical Source-Drain Diode Forward Voltage

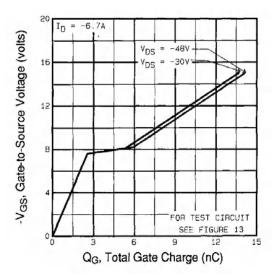


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

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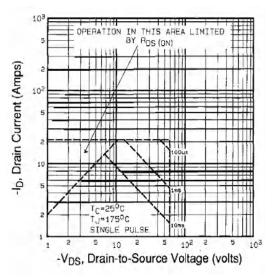


Fig. 8 - Maximum Safe Operating Area



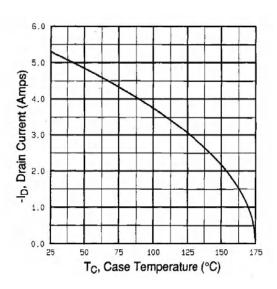


Fig. 9 - Maximum Drain Current vs. Case Temperature

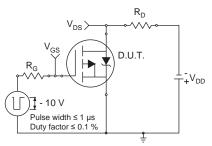


Fig. 10a - Switching Time Test Circuit

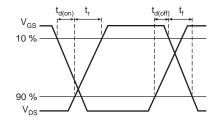


Fig. 10b - Switching Time Waveforms

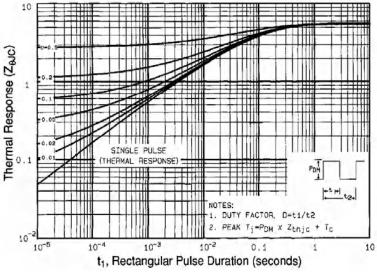


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

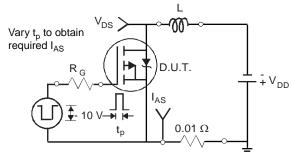


Fig. 12a - Unclamped Inductive Test Circuit

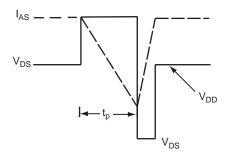


Fig. 12b - Unclamped Inductive Waveforms



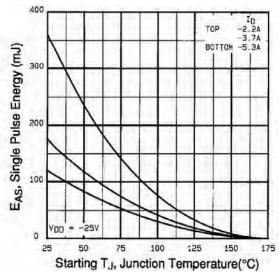


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

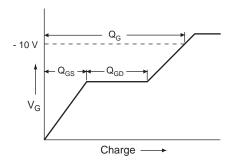


Fig. 13a - Basic Gate Charge Waveform

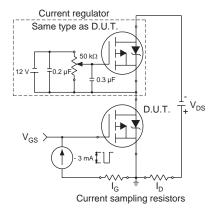
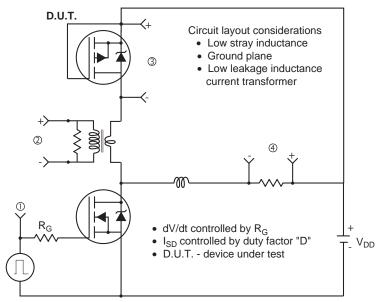


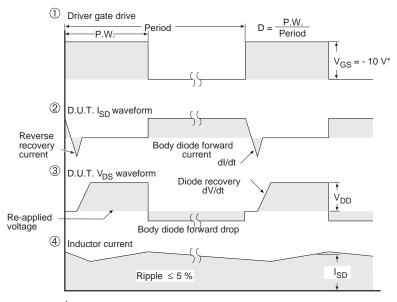
Fig. 13b - Gate Charge Test Circuit



# Peak Diode Recovery dV/dt Test Circuit



• Compliment N-Channel of D.U.T. for driver

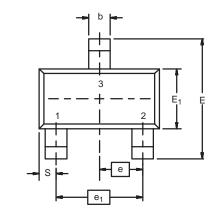


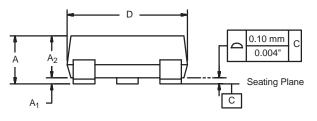
V<sub>GS</sub> = -5 V for logic level and -3 V drive devices

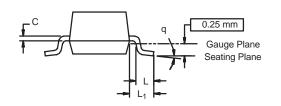
Fig. 14 - For P-Channel



# SOT-23 (TO-236): 3-LEAD







Dim	MILLIM	IETERS	INCHES		
	Min	Max	Min	Max	
Α	0.89	1.12	0.035	0.044	
A <sub>1</sub>	0.01	0.10	0.0004	0.004	
A <sub>2</sub>	0.88	1.02	0.0346	0.040	
b	0.35	0.50	0.014	0.020	
С	0.085	0.18	0.003	0.007	
D	2.80	3.04	0.110	0.120	
E	2.10	2.64	0.083	0.104	
E <sub>1</sub>	1.20	1.40	0.047	0.055	
е	0.95	0.95 BSC		0.0374 Ref	
e <sub>1</sub>	1.90	1.90 BSC		8 Ref	
L	0.40	0.60	0.016	0.024	
L <sub>1</sub>	0.64	0.64 Ref		5 Ref	
S	0.50 Ref		0.020	) Ref	
q	3°	8°	3°	8°	

DWG: 5479



## **RECOMMENDED MINIMUM PADS FOR SOT-23**



Recommended Minimum Pads Dimensions in Inches/(mm)



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